DOCUMENT CHANGE REQUEST

DCR number 1131	Changes required for: General	Originator: Steve Thacker
Date: 2018/01/31	Date sent: 2017/12/08	Organisation: ESCC Executive Secretariat
Status: IMPLEMENTED		

Title:	Generic Specification for Thermistors (Resistors Thermally Sensitive)		
Number:	4006	Issue:	3

Other documents affected:

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Paragraph:

12.4 Chart F4

Original wording:

Note 3: This Subgroup of tests shall be performed only if the maximum storage temperature of the devices is higher than their maximum operating temperature.

Note 4: To be performed only if the maximum storage temperature of the devices is equal to their maximum operating temperature.

Proposed wording:

Add a reference to the Detail Specification for the definition of the maximum storage and operating temperatures for clarification purposes.
i.e. Amend Notes 3 & 4 to read as follows:
3. This Subgroup of tests shall be performed only if the Maximum Storage Temperature of the components, as specified in Maximum Ratings in the Detail Specification, is higher than the Maximum Operating Temperature, also as specified in Maximum Ratings in the Detail Specification.

4. This test shall be performed only if the Maximum Storage Temperature of the components, as specified in Maximum Ratings in the Detail Specification, is equal to the Maximum Operating Temperature, also as specified in Maximum Ratings in the Detail Specification.

Justification:

For clarification purposes.
i.e. to make it clear that the specific maximum storage and operating temperatures as specified in the Detail Specification should be used to decide the applicable test requirements (not any other arbitrary operating or storage temperatures).

Attachments:
escc4006_draft_4___dcr_on_chart_f4.docx
Modifications:
N/A
Approval signature:

Date signed:
2018-01-31